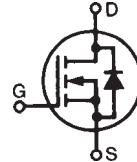


PolarHT™ Power MOSFET

**IXTQ 110N10P
IXTT 110N10P**

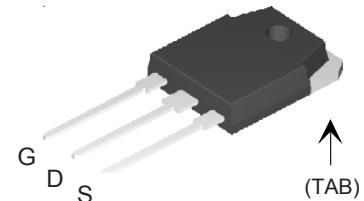
**V_{DSS} = 100 V
I_{D25} = 110 A
R_{DS(on)} ≤ 15 mΩ**

N-Channel Enhancement Mode
Avalanche Rated

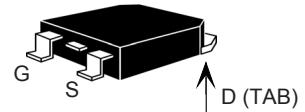


Symbol	Test Conditions	Maximum Ratings		
V _{DSS}	T _J = 25°C to 175°C	100	V	
V _{DGR}	T _J = 25°C to 175°C; R _{GS} = 1 MΩ	100	V	
V _{GS}	Continuous	±20	V	
V _{GSM}	Transient	±30	V	
I _{D25}	T _c = 25°C	110	A	
I _{D(RMS)}	External lead current limit	75	A	
I _{DM}	T _c = 25°C, pulse width limited by T _{JM}	250	A	
I _{AR}	T _c = 25°C	60	A	
E _{AR}	T _c = 25°C	40	mJ	
E _{AS}	T _c = 25°C	1.0	J	
dv/dt	I _S ≤ I _{DM} , di/dt ≤ 100 A/μs, V _{DD} ≤ V _{DSS} , T _J ≤ 150°C, R _G = 4 Ω	10	V/ns	
P _D	T _c = 25°C	480	W	
T _J		-55 ... +175	°C	
T _{JM}		175	°C	
T _{stg}		-55 ... +150	°C	
T _L	1.6 mm (0.062 in.) from case for 10 s	300	°C	
T _{SOLD}	Plastic body for 10 s	260	°C	
M _d	Mounting torque (TO-3P)	1.13/10	Nm/lb.in.	
Weight	TO-3P	5.5	g	
	TO-268	5.0	g	

TO-3P (IXTQ)



TO-268 (IXTT)



G = Gate
S = Source
TAB = Drain

Features

- International standard packages
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
 - easy to drive and to protect

Advantages

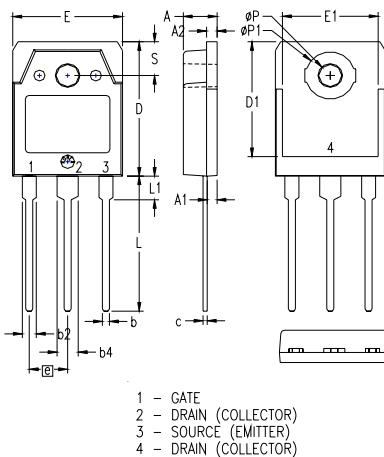
- Easy to mount
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values		
	(T _J = 25°C, unless otherwise specified)	Min.	Typ.	Max.
BV _{DSS}	V _{GS} = 0 V, I _D = 250 μA	100		V
V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2.5		5.0 V
I _{GSS}	V _{GS} = ±20 V _{DC} , V _{DS} = 0		±100	nA
I _{DSS}	V _{DS} = V _{DSS} V _{GS} = 0 V		25 250	μA
R _{DS(on)}	V _{GS} = 10 V, I _D = 0.5 I _{D25} Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %		15	mΩ

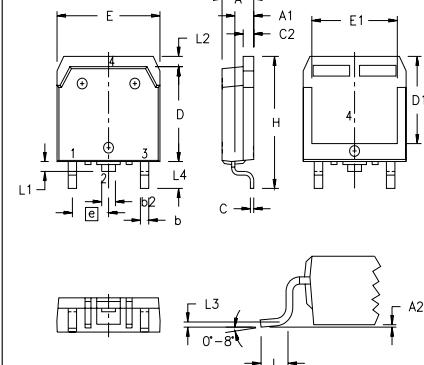
Symbol	Test Conditions	Characteristic Values			
		($T_J = 25^\circ C$, unless otherwise specified)	Min.	Typ.	Max.
g_{fs}	$V_{DS} = 10 V$; $I_D = 0.5 I_{D25}$, pulse test	30	40	S	
C_{iss} C_{oss} C_{rss}	$V_{GS} = 0 V$, $V_{DS} = 25 V$, $f = 1 MHz$	3550	pF		
		1370	pF		
		440	pF		
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	$V_{GS} = 10 V$, $V_{DS} = 0.5 V_{DSS}$, $I_D = 0.5 I_{D25}$ $R_G = 4 \Omega$ (External)	21	ns		
		25	ns		
		65	ns		
		25	ns		
$Q_{g(on)}$ Q_{gs} Q_{gd}	$V_{GS} = 10 V$, $V_{DS} = 0.5 V_{DSS}$, $I_D = 0.5 I_{D25}$	110	nC		
		25	nC		
		62	nC		
R_{thJC}				0.31	°C/W
R_{thcs}	(TO-3P)	0.21			°C/W

Source-Drain Diode
Characteristic Values
($T_J = 25^\circ C$, unless otherwise specified)

Symbol	Test Conditions	Min.	Typ.	Max.
I_s	$V_{GS} = 0 V$		110	A
I_{SM}	Repetitive		250	A
V_{SD}	$I_F = I_s$, $V_{GS} = 0 V$, Pulse test, $t \leq 300 \mu s$, duty cycle $d \leq 2\%$		1.5	V
t_{rr} Q_{RM}	$I_F = 25 A$, $-di/dt = 100 A/\mu s$ $V_R = 50 V$, $V_{GS} = 0 V$	130	ns	
		2.0		μC

TO-3P (IXTQ) Outline

 1 - GATE
 2 - DRAIN (COLLECTOR)
 3 - SOURCE (EMITTER)
 4 - DRAIN (COLLECTOR)

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.185	.193	4.70	4.90
A1	.051	.059	1.30	1.50
A2	.057	.065	1.45	1.65
b	.035	.045	0.90	1.15
b2	.075	.087	1.90	2.20
b4	.114	.126	2.90	3.20
c	.022	.031	0.55	0.80
D	.780	.799	19.80	20.30
D1	.665	.677	16.90	17.20
E	.610	.622	15.50	15.80
E1	.531	.539	13.50	13.70
e	.215 BSC		5.45 BSC	
L	.779	.795	19.80	20.20
L1	.134	.142	3.40	3.60
ØP	.126	.134	3.20	3.40
ØP1	.272	.280	6.90	7.10
S	.193	.201	4.90	5.10

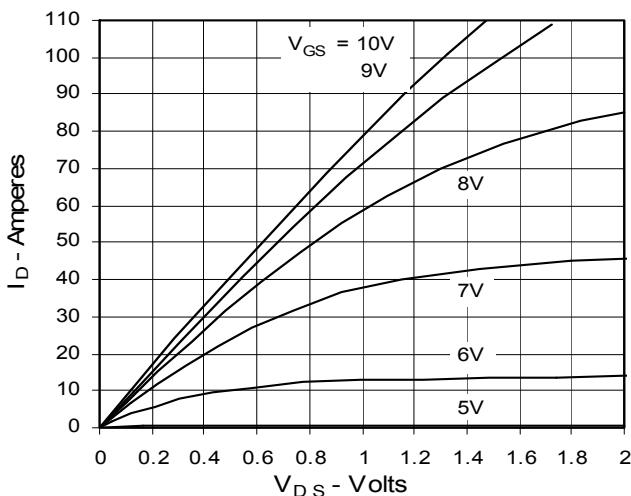
TO-268 (IXTT) Outline

 1 - GATE
 2 - DRAIN (COLLECTOR)
 3 - SOURCE (EMITTER)
 4 - DRAIN (COLLECTOR)

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.193	.201	4.90	5.10
A1	.106	.114	2.70	2.90
A2	.001	.010	0.02	0.25
b	.045	.057	1.15	1.45
b2	.075	.083	1.90	2.10
C	.016	.026	0.40	0.65
C2	.057	.063	1.45	1.60
D	.543	.551	13.80	14.00
D1	.488	.500	12.40	12.70
E	.624	.632	15.85	16.05
E1	.524	.535	13.30	13.60
e	.215 BSC		5.45 BSC	
H	.736	.752	18.70	19.10
L	.094	.106	2.40	2.70
L1	.047	.055	1.20	1.40
L2	.039	.045	1.00	1.15
L3	.010 BSC		0.25 BSC	
L4	.150	.161	3.80	4.10

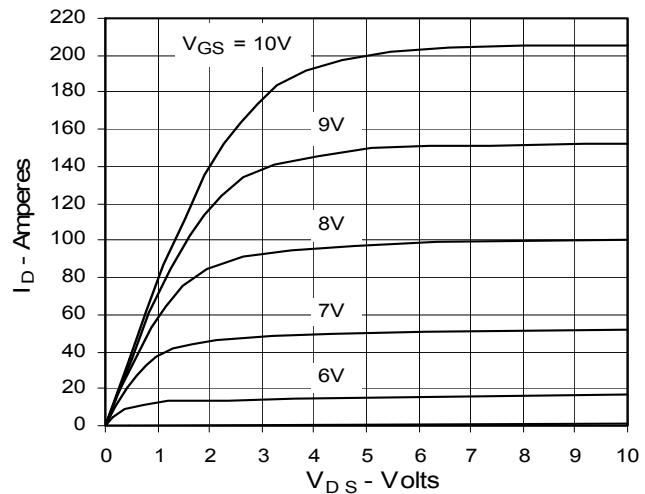
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405B2 6,759,692 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2

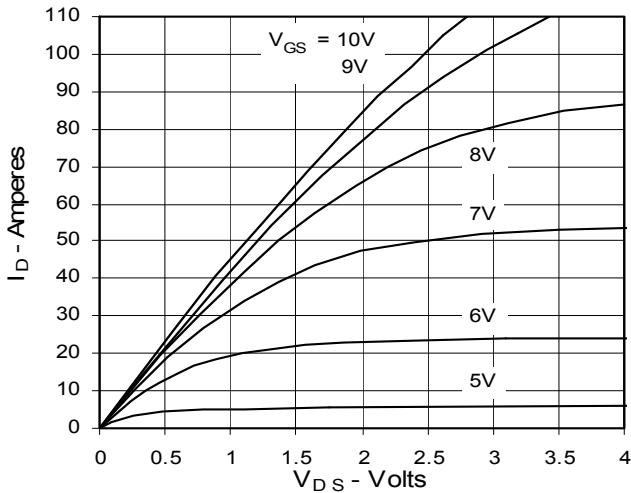
**Fig. 1. Output Characteristics
@ 25°C**



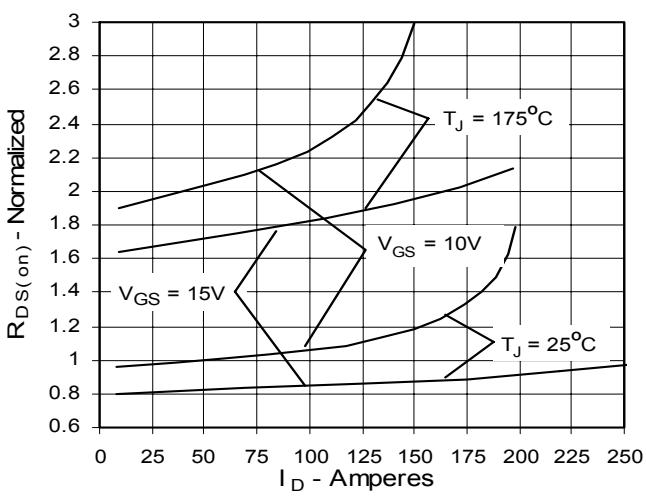
**Fig. 2. Extended Output Characteristics
@ 25°C**



**Fig. 3. Output Characteristics
@ 150°C**



**Fig. 5. $R_{DS(on)}$ Normalized to 0.5 I_{D25}
Value vs. Drain Current**



**Fig. 4. $R_{DS(on)}$ Normalized to 0.5 I_{D25}
Value vs. Junction Temperature**

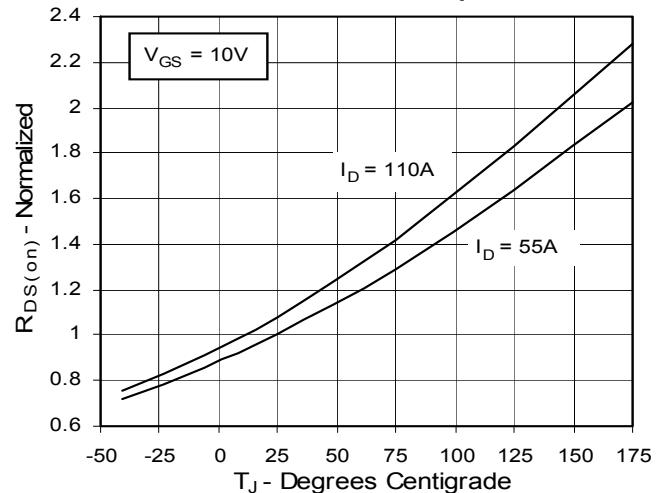


Fig. 6. Drain Current vs. Case Temperature

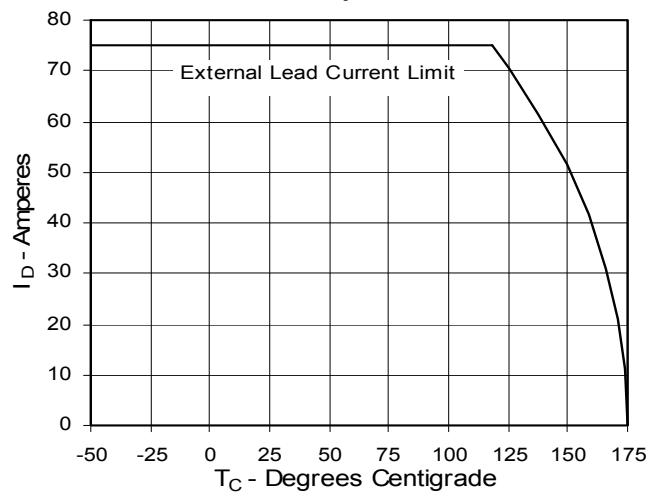


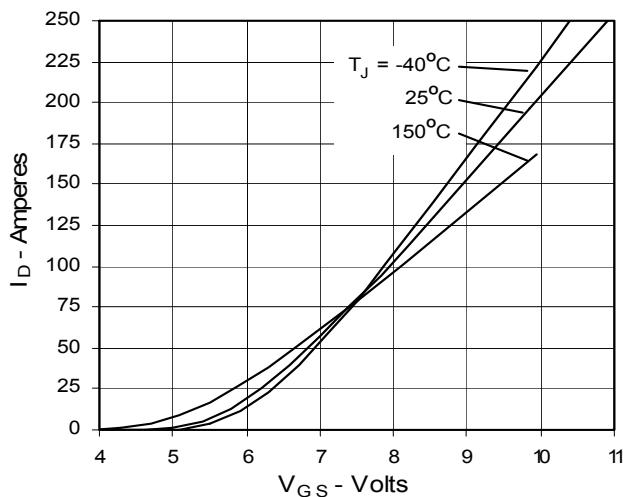
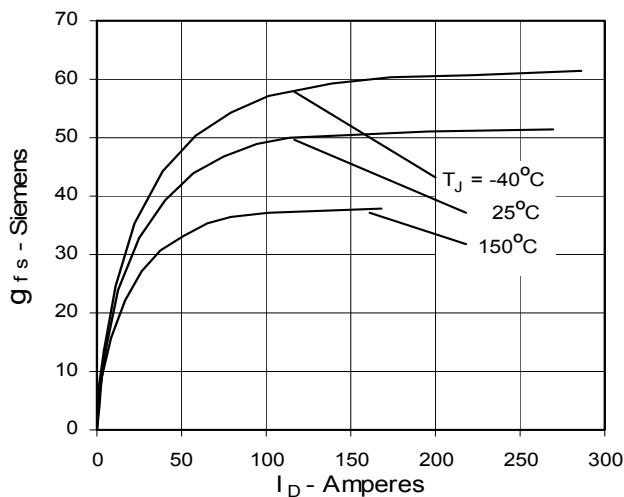
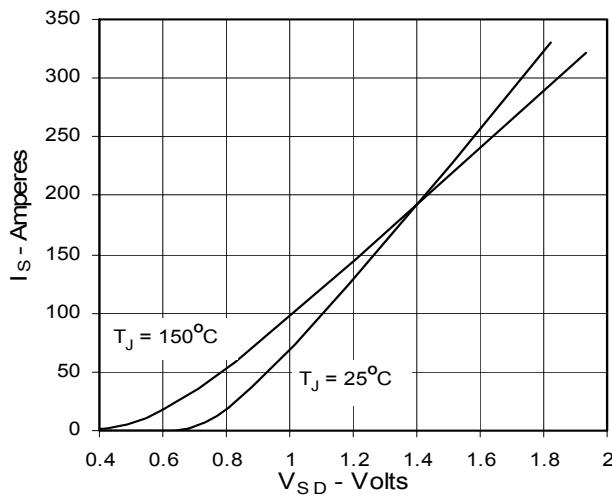
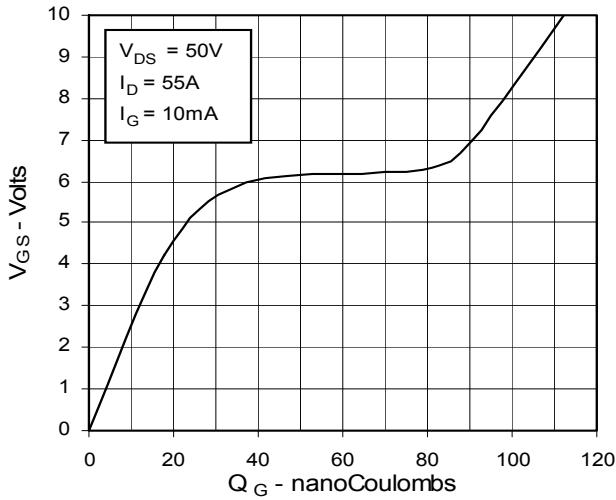
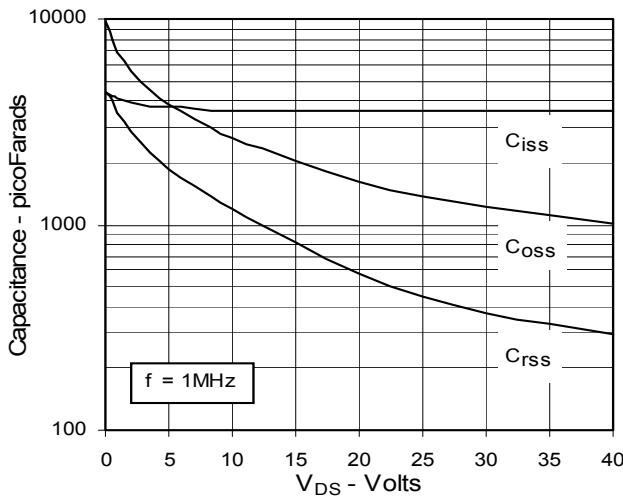
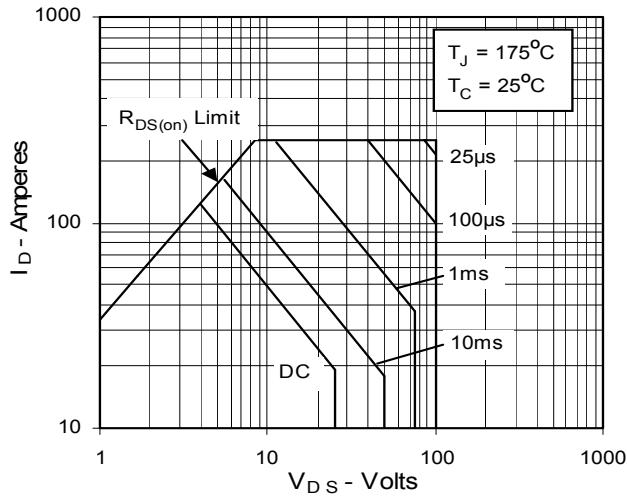
Fig. 7. Input Admittance

Fig. 8. Transconductance

Fig. 9. Source Current vs. Source-To-Drain Voltage

Fig. 10. Gate Charge

Fig. 11. Capacitance

Fig. 12. Forward-Bias Safe Operating Area


Fig. 13. Maximum Transient Thermal Resistance